Application/Control No.	Applicant(s)/Patent under Reexamination	
10/626,569	ISHII ET AL.	
Examiner	Art Unit	
Susan W. Berman	1711	

SEARCHED						
Cla	ass	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
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above	above	6/21/2005	SB		
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EAST update	6/21/2005	SB
inventor	6/21/2005	SB